

Notice of References Cited		Application/Control No. 10/553,112	Applicant(s)/Patent Under Reexamination KIEREN ET AL.	
		Examiner Chuong P. Nguyen	Art Unit 3663	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0069006 A1	06-2002	Faye et al.	701/70
*	B	US-6,438,463 B1	08-2002	Tobaru et al.	701/1
*	C	US-6,494,281 B1	12-2002	Faye et al.	180/197
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	K	US-			
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NON-PATENT DOCUMENTS

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